## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10089178	HIBINO ET AL.
Examiner	Art Unit
DEVONA E FAULK	2615

SEARCHED							
Class	Subclass	Date	Examiner				
381	86	5/31/06	BTP				
381	86,302,102-109	4/26/07	DEF				
381	86,302,102-109	5/19/08	DEF				
455	345,569.2	5/20/08	DEF				
381	302,86	12/7/08	DEF				
381	302,86,102-109,74,24,25	5/7/09	DEF				
455	569.2,345	5/7/09	DEF				
381	102-109,86,302,74	11/20/09	DEF				
455	569.2,345	11/20/09	DEF				

SEARCH NOTES			
Search Notes	Date	Examiner	
Assignee/Inventor search	4/26/07	DEF	
reviewed applicant's arguments, maintained rejection	10/18/07	DEF	
additonal search	5/19/08	DEF	
additional search	12/7/08	DEF	
additional search	5/7/09	DEF	
additional search	11/20/09	DEF	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examine

/DEVONA E FAULK/ Primary Examiner.Art Unit 2614

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